

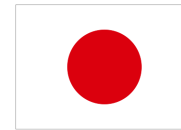
Update on CALICE/DRD Calo SiW Ecal

- Tracing the Odds -

Roman Pöschl



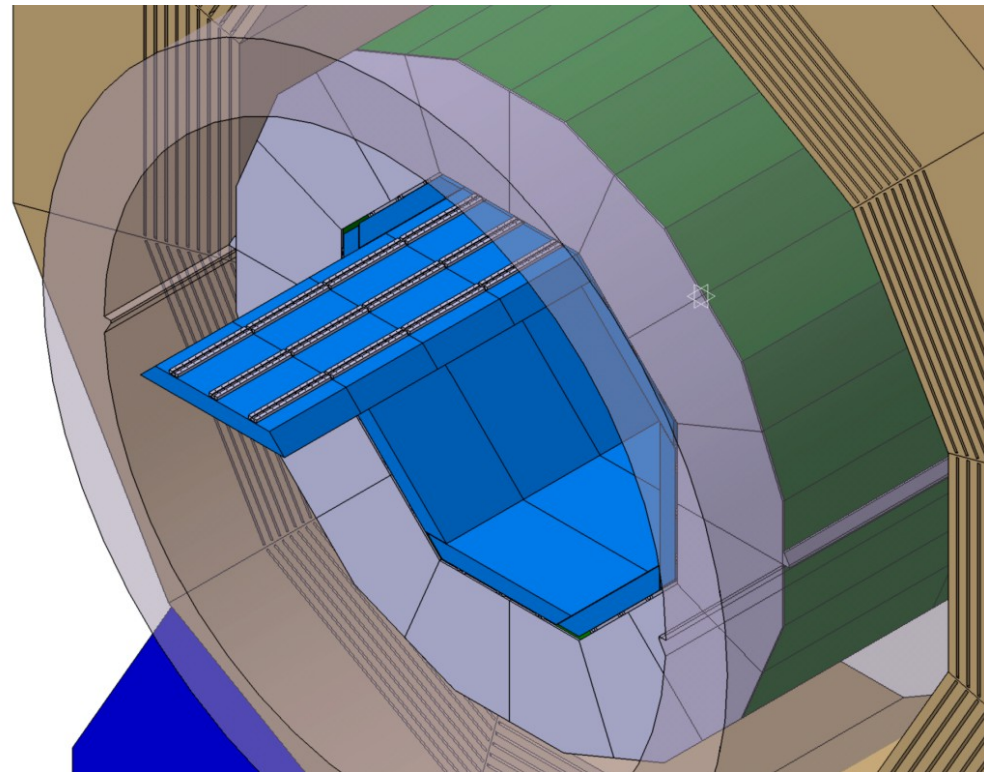
On behalf of the SiW ECAL Groups in CALICE/DRD Calo:



CALOR 2024 – Tsukuba/Japan May 2024

This project has received funding from the European Union's Horizon 2020 Research and Innovation programmes under GAs no 101004761 and 101086276

Optimised for Particle Flow: Jet energy resolution 3-4%, Excellent photon-hadron separation



The SiW ECAL in the ILD Detector

- $O(10^8)$ cells
- “No space”
- => Large integration effort

Basic Requirements:

- Extreme high granularity
- Compact and hermetic
(inside magnetic coil)

Basic Choices:

Tungsten as absorber material
 $X_0=3.5\text{mm}$, $R_M=9\text{mm}$, $\lambda_I=96\text{mm}$

Narrow showers

Assures compact design

Silicon as active material

Support compact design

Allows for pixelisation Robust technology

Excellent signal/noise ratio: 10 as design value

- All future e^+e^- collider projects feature at least one detector concept with this technology
- Application in small and medium size experiments as LUXE, Lohengrin, EBES, Ship (?)

ASIC+PCB+SiWafer
=ASU

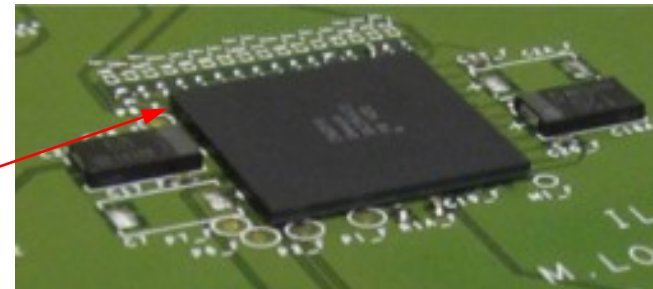
Size 18x18 cm²

(IJCLab, Kyushu, OMEGA, LLR, SKKU)



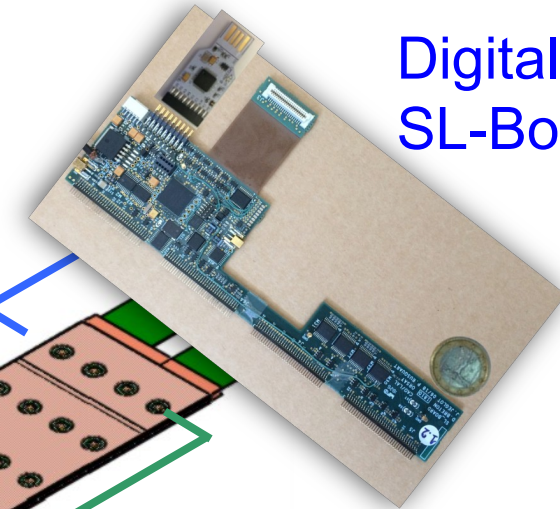
ASIC SKIROC2(a)
 (OMEGA)

Wire Bonded or
In BGA package
 (IJCLab, Kyushu, LLR)

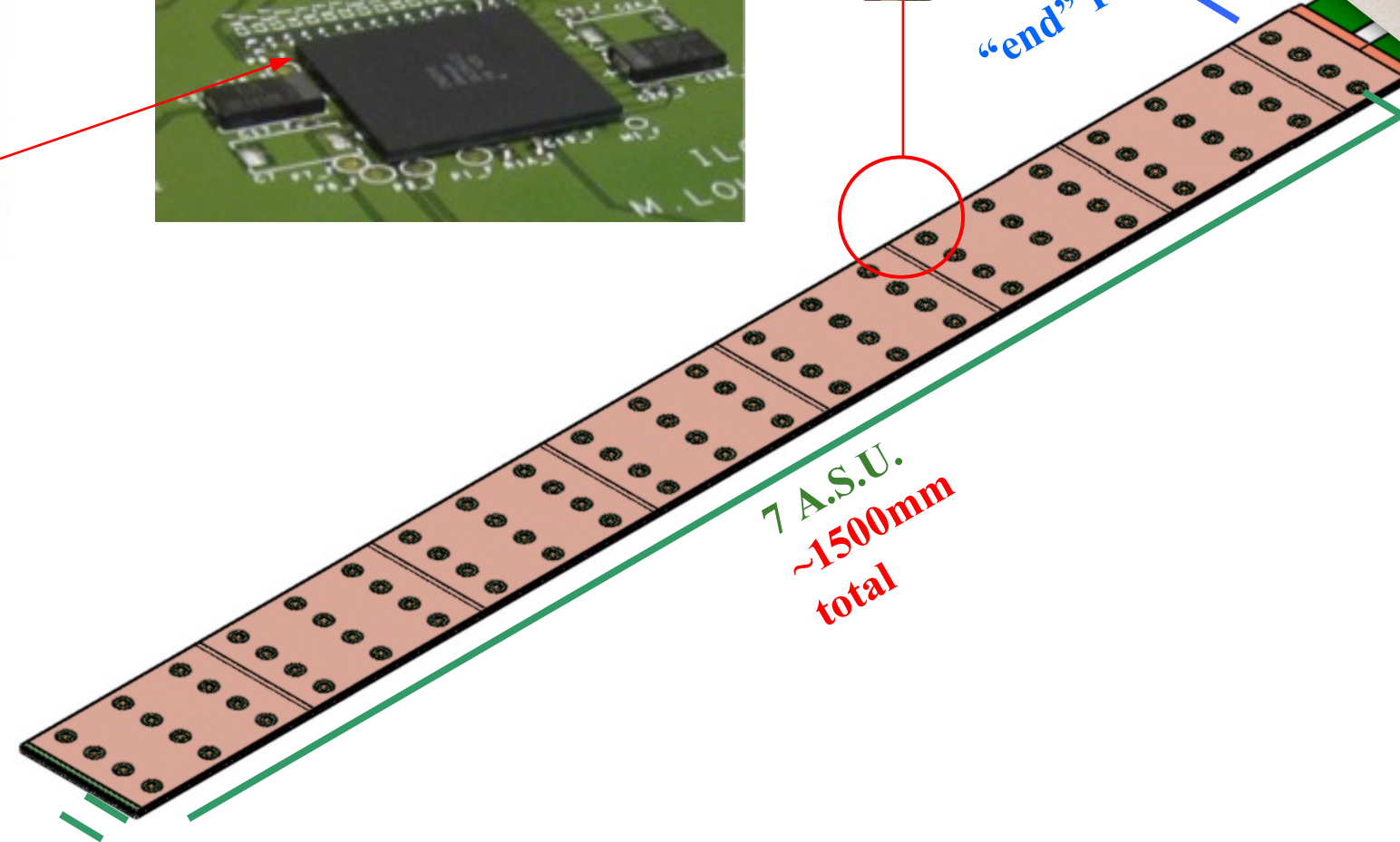


Interconnection
 (IJCLab)

Digital readout
 SL-Board (IJCLab)



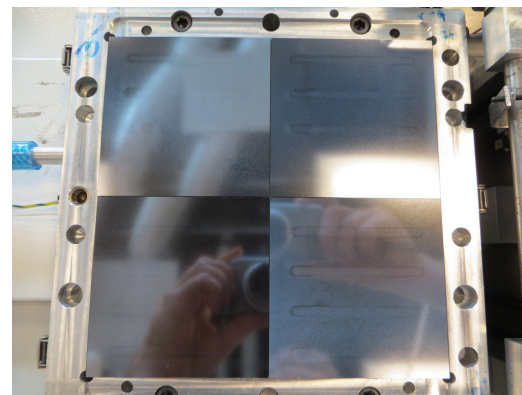
“end” PCB



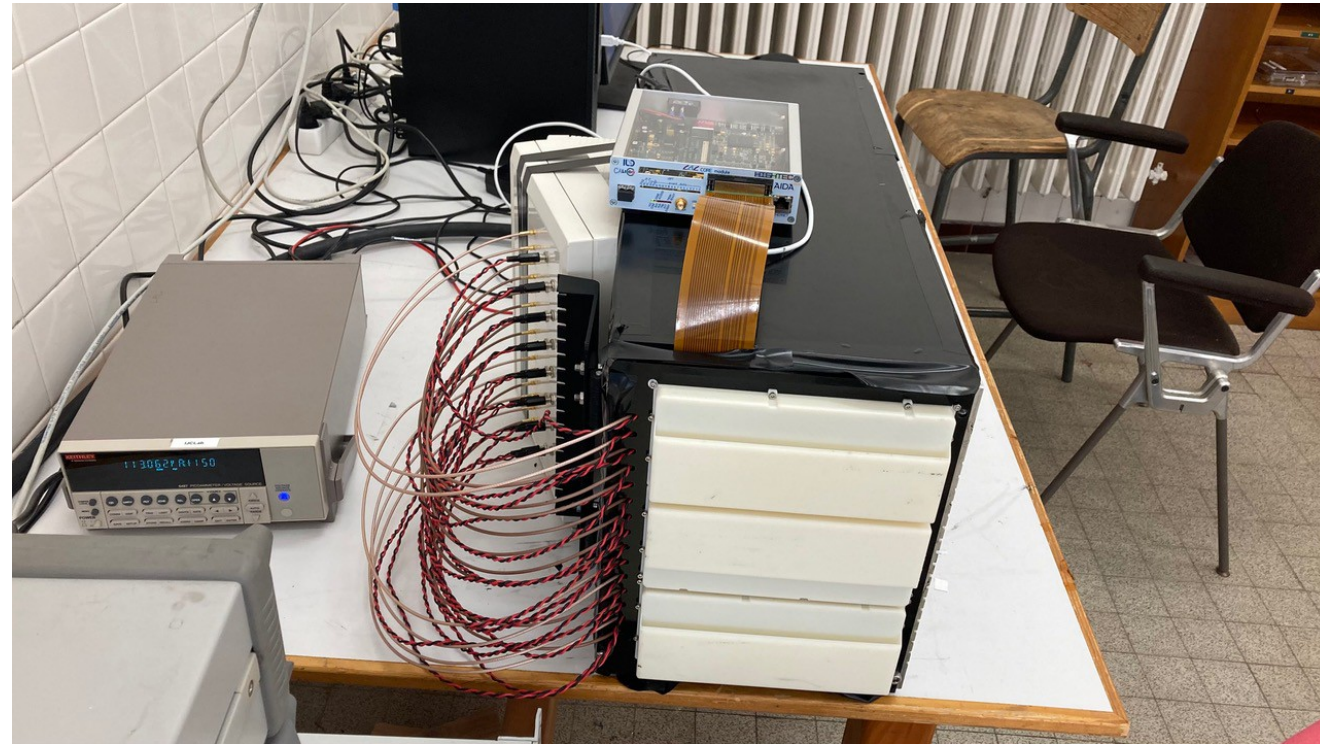
7 A.S.U.
 ~1500mm
 total

SiWafers
glued
onto PCB

Pixel size
 5.5x5.5 mm²
 (LPNHE)

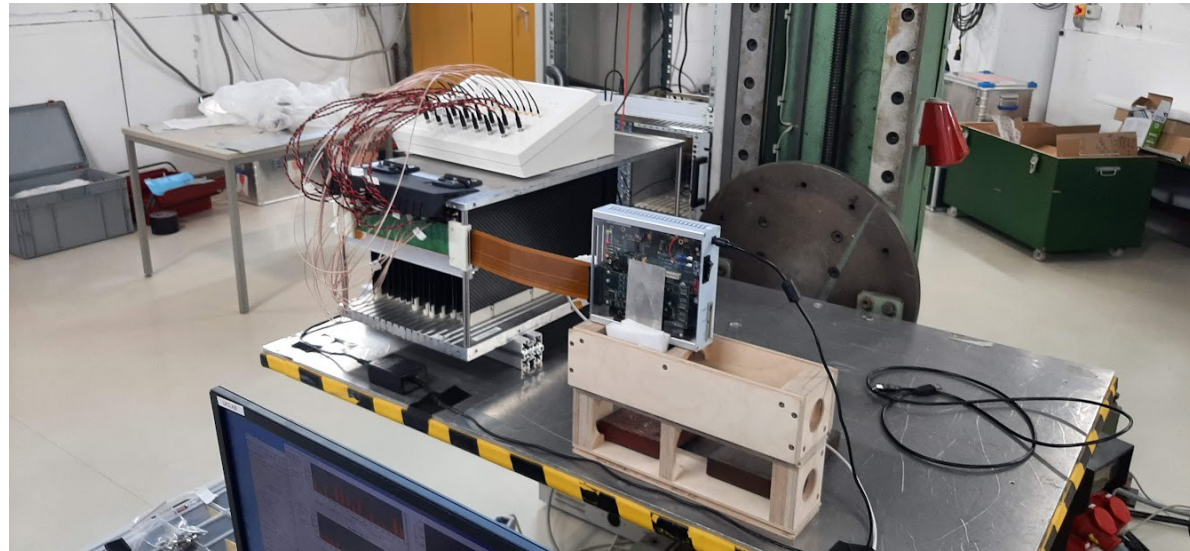


The beam test set up will consist of a **stack of short layers** consisting of one ASU and a readout card each

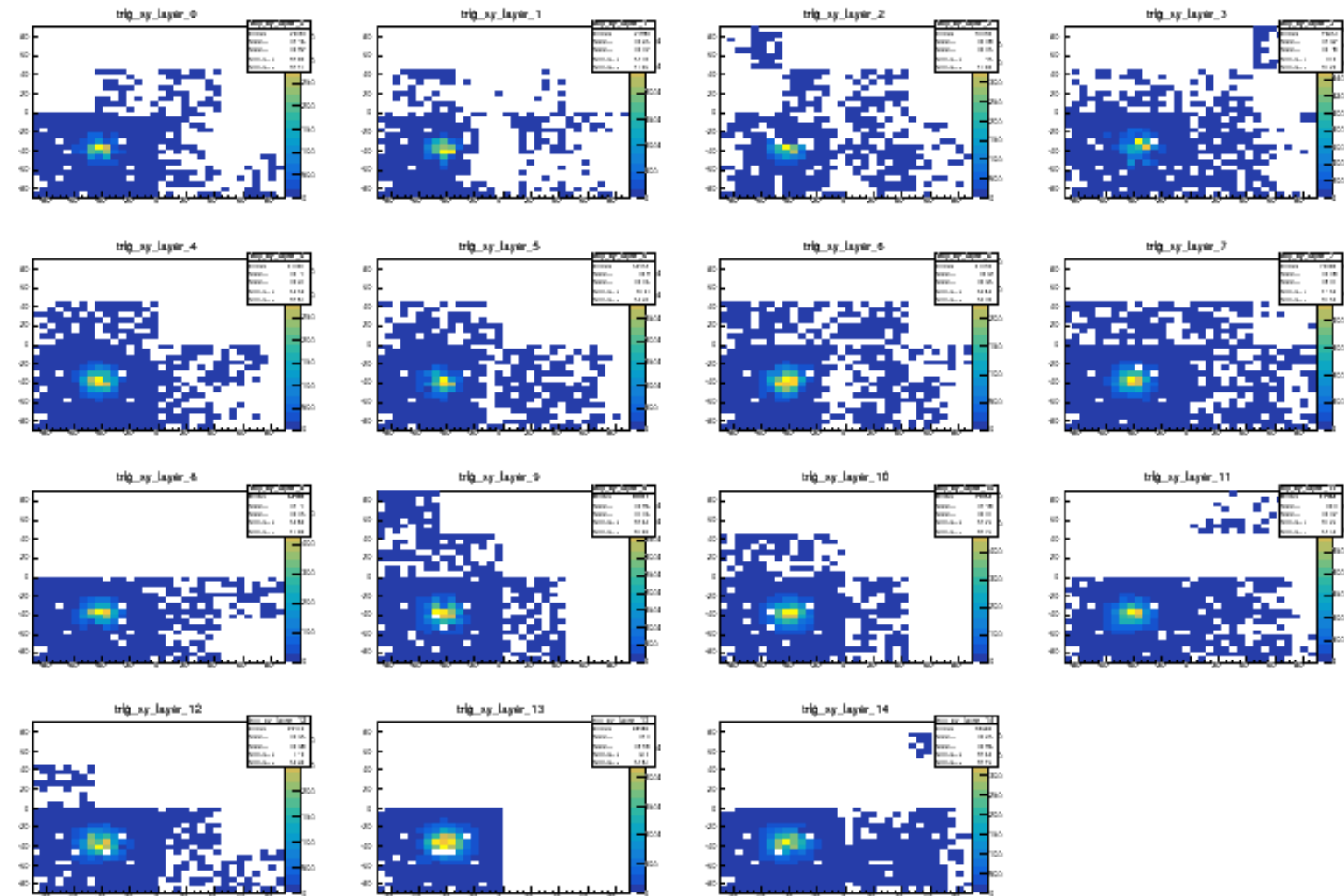


- 15 short layers equivalent to 15360 readout cells
 - Up to $21 X_0$
 - Most of the layers produced 2016 - 2017
- Commissioned 2020-2022
 - ~450000 calibration constants for one ASIC feedback capa setting
- Testbeams (finally) in November 2021 and during 2022
- Mainly technical tests but also first real showers
- This talk ...
 - Lessons from the 2021/22 beam tests and the preparation of the upgrade of the stack

Detector Setup

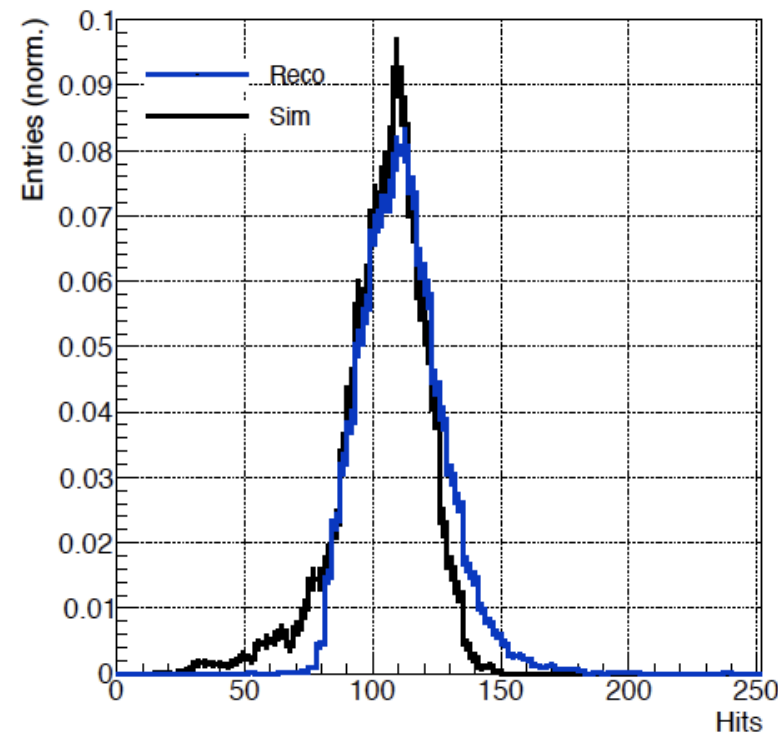


Detector in beam position

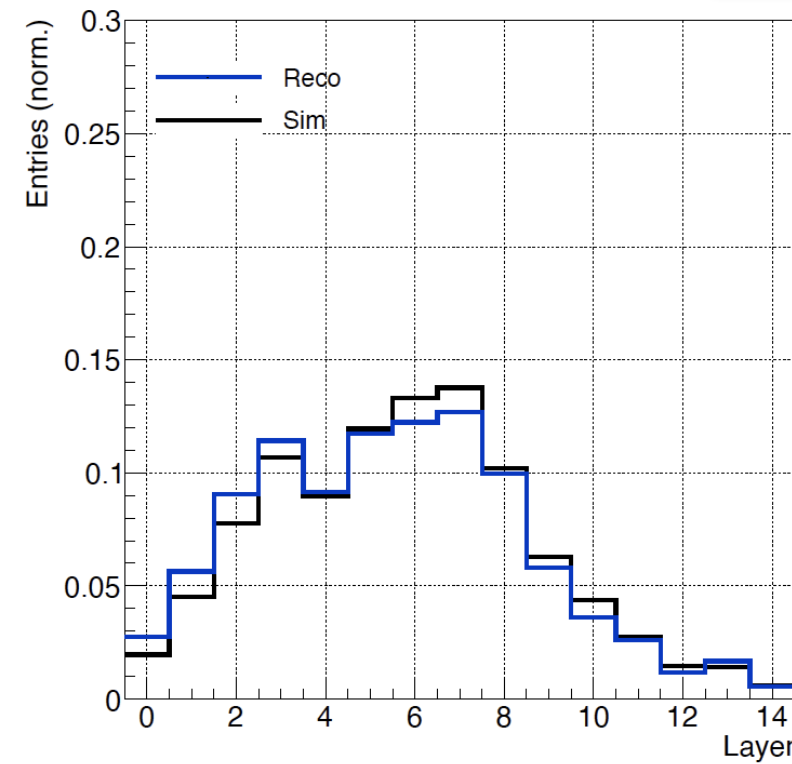


Beam spot in 15 layers

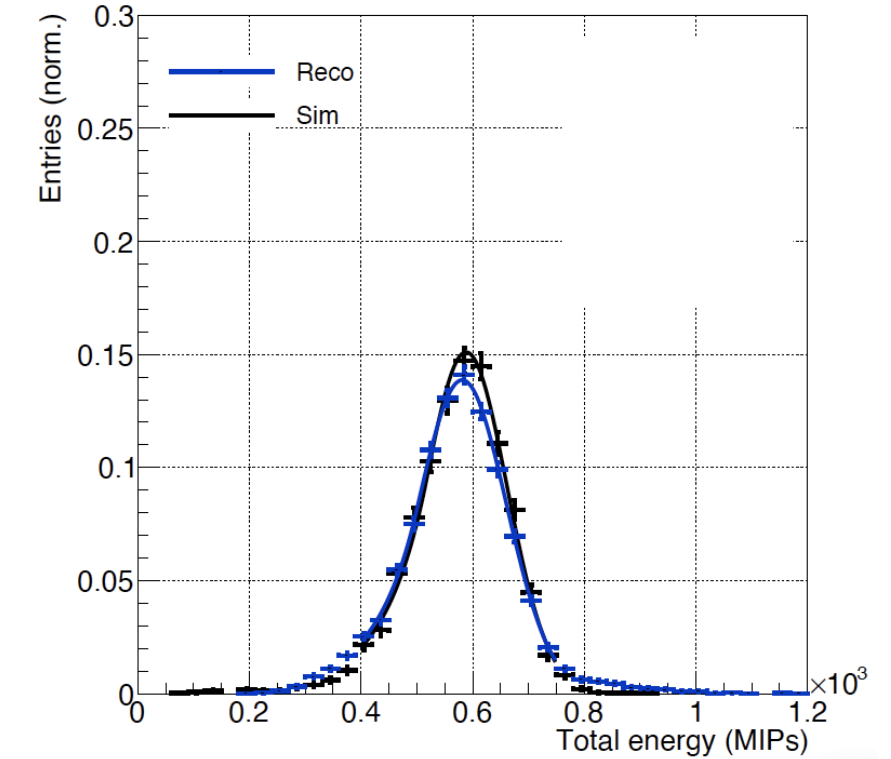
Total #of hits



Hits/layer



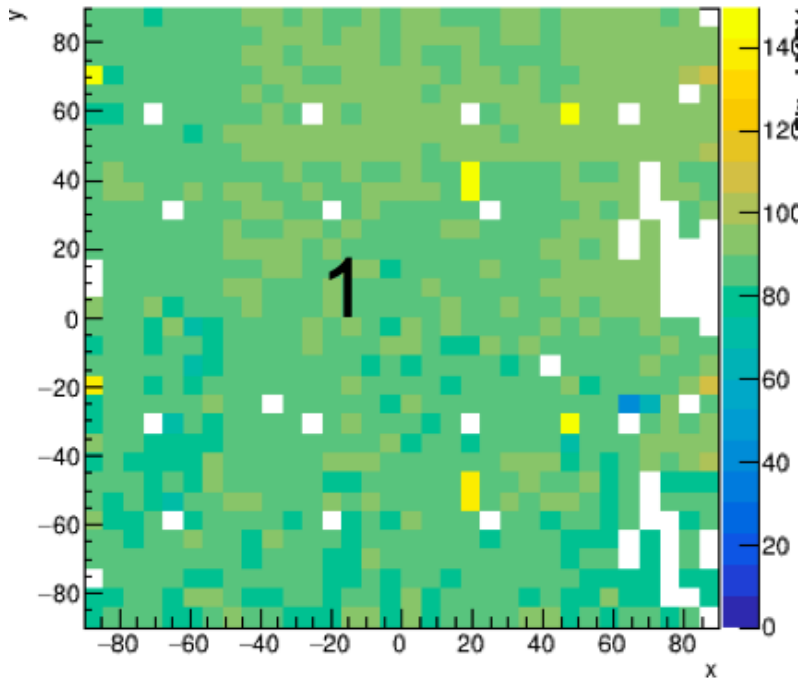
(Total Energy)/MIPS



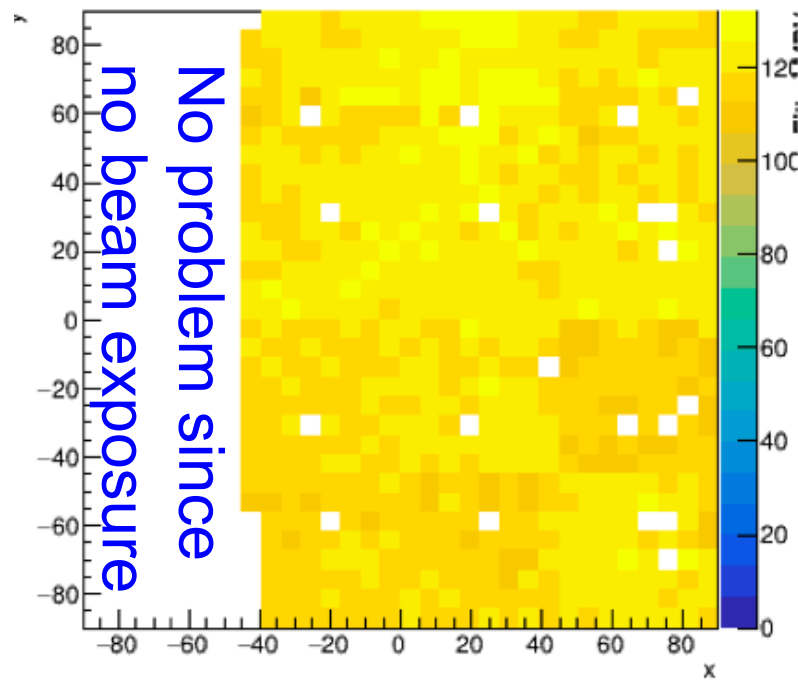
- Reasonable agreement between data and MC
 - ,, , after correction of MC for acceptance issues and adjusting the beam spot
- Energy resolution in ball park expected from simulation
- More analysis work required (including combined analyses)

PhD Thesis Y. Okugawa, IJCLab and Tohoku University

mpv_layer7_xy



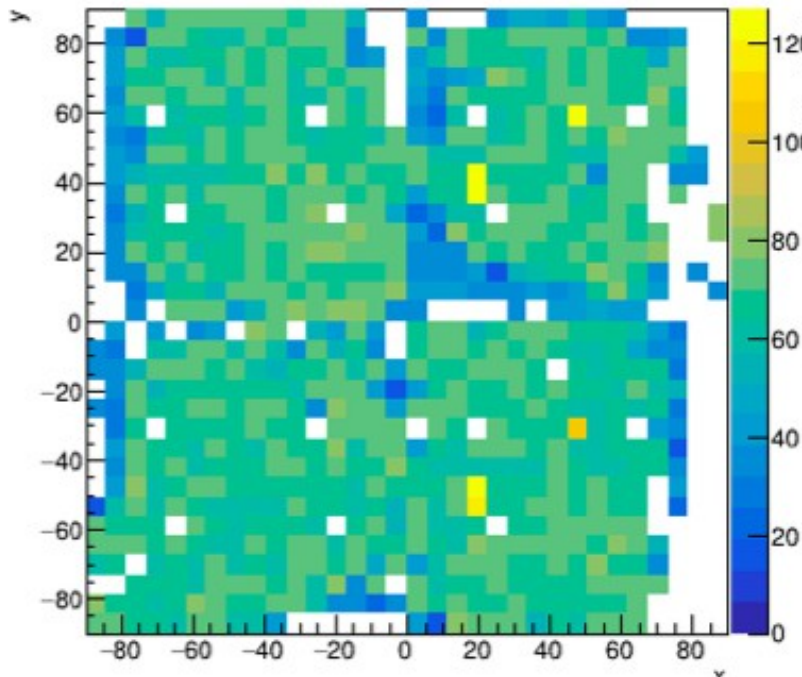
mpv_layer3_xy



We have good layers ...

- Homogeneous response to MIPs over layer surface
- > 90% efficiency for MIPs
- Here white cells are masked cells due to PCB routing
 - understood and corrected

mpv_layer4_xy



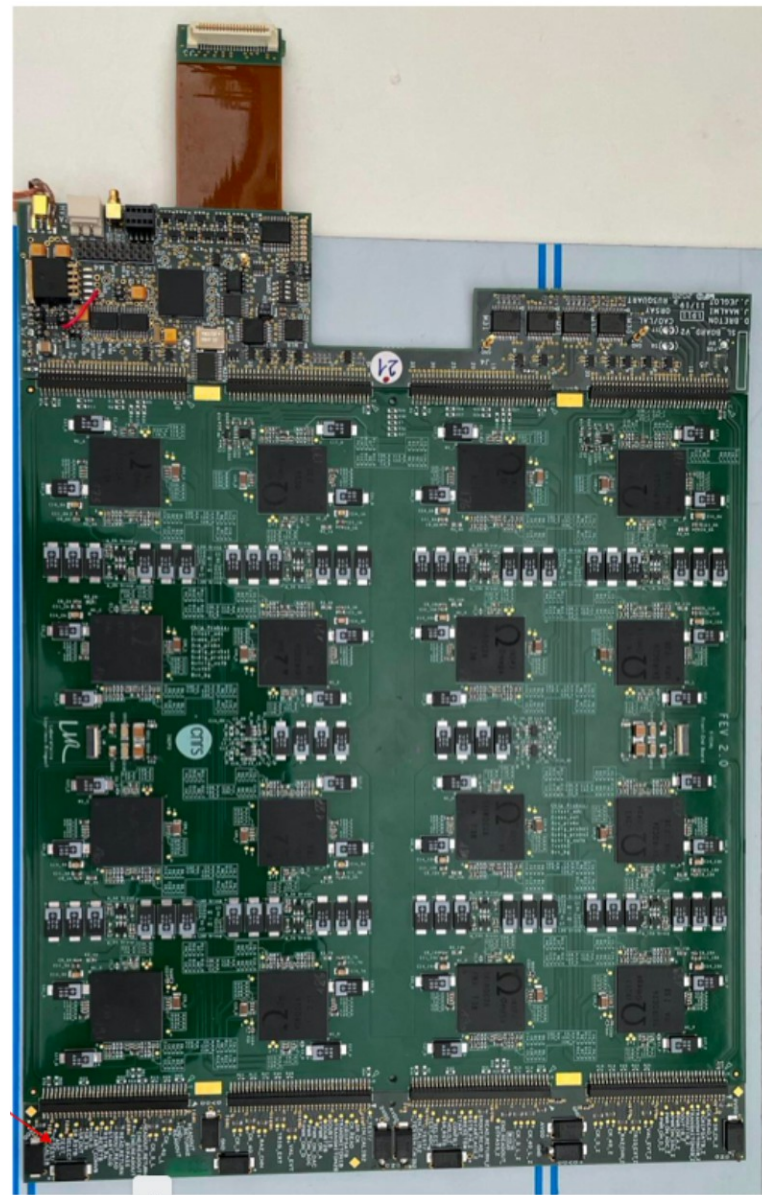
... and bad layers

Inhomogeneous response to MIPs

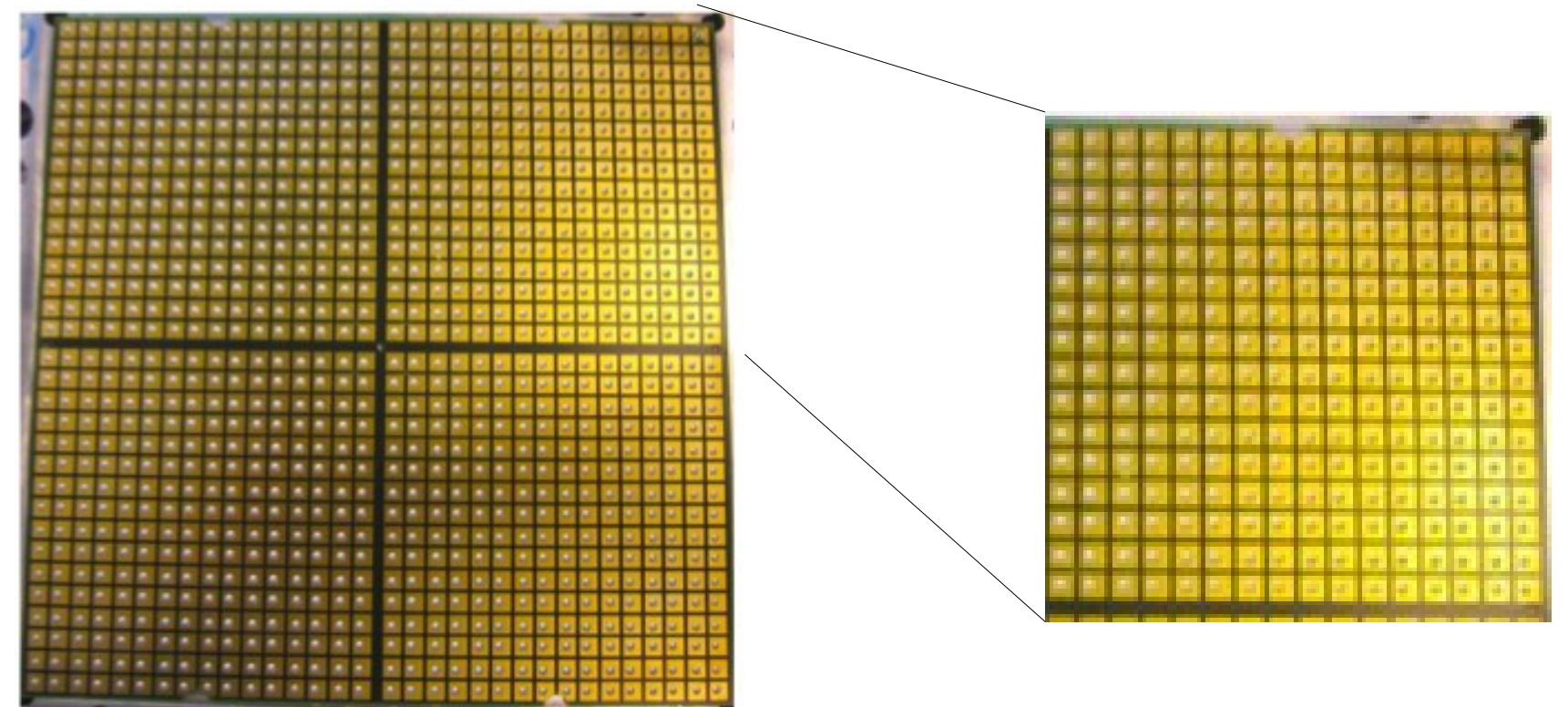
- Partially even no response at all, in particular at the sensor boundaries
- Visual inspection confirmed with electrical tests show that the sensor got delaminated from the PCB -> glue dots have failed
- **Serious problem and intensive topic of study**

Overall size – 18x18x~0.5cm³

Upside: PCB with Electronics



Downside: Si sensors (here glass plates) glued to PCB

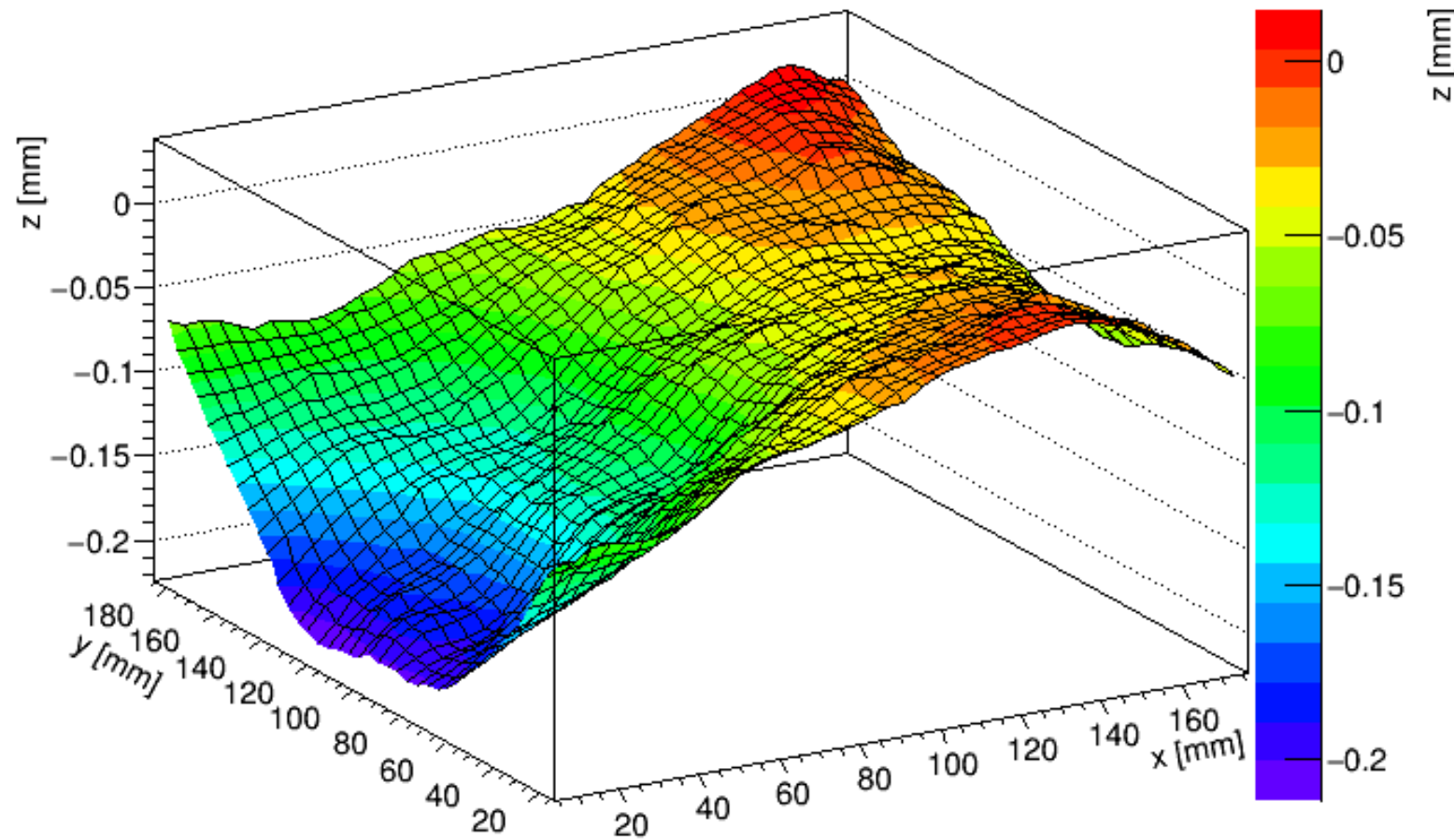


Glue: Epotek 4110 (conductive glue)
Dimensions of glue dots ~Ø 2.5mmx0.1mm

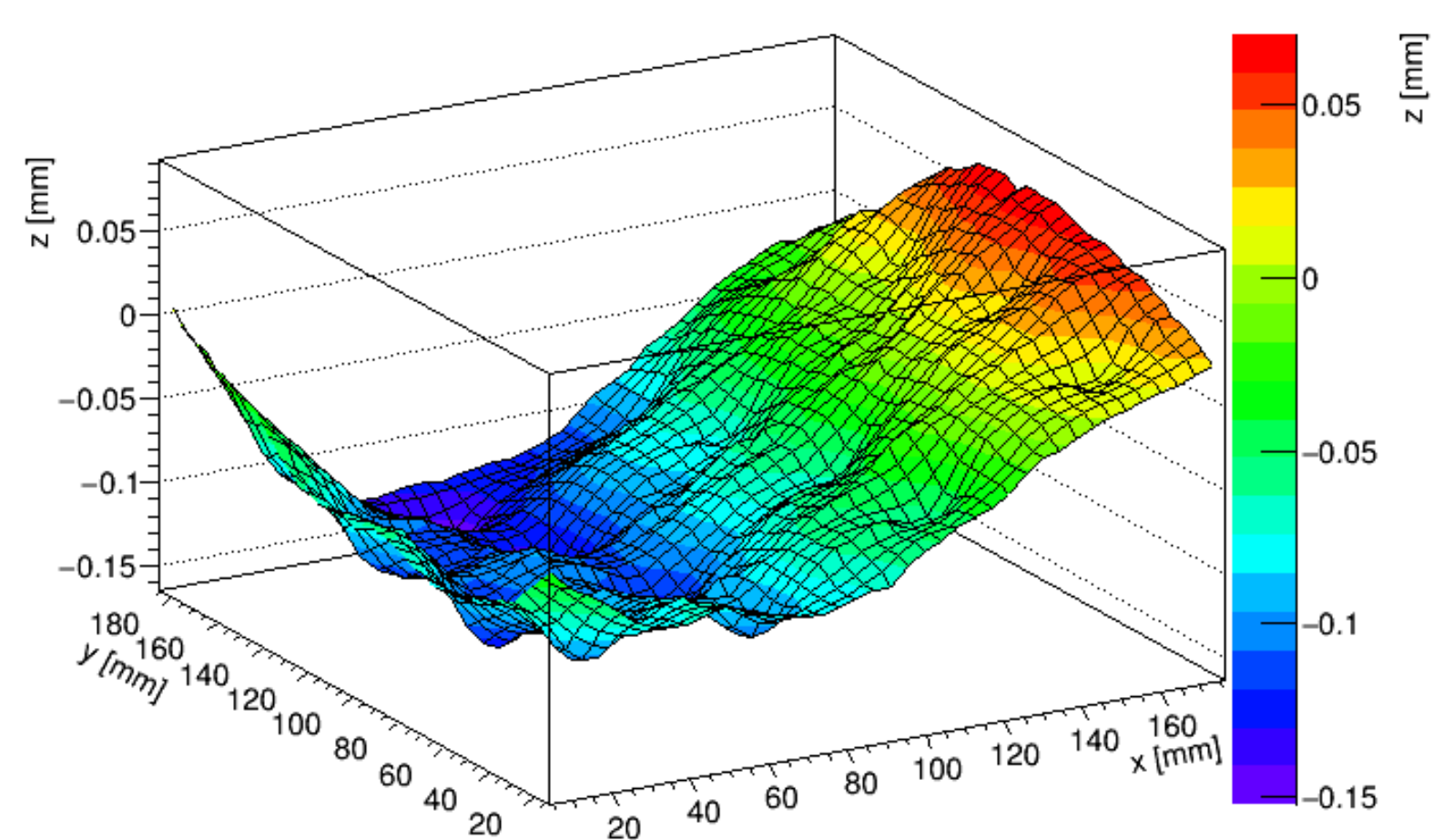
- Hypothesis and foundation
 - Deformation of PCBs pulls on glue dots
 - Conductive glue has no mechanical stability and unpredictable behaviour (dixit Epotek)
 - Replace Epotek 4110 by Epotek H20E after consultation of other research teams and Epotek
- Metrology
 - What are the deformations we are dealing with?
- Hybridisation
 - Develop methods that allow keeping constant the distance between PCB and sensor
- Stress tests

Several PCBs were measured at IJCLab before and after mounting of components in IJCLab Workshop
Component mounting includes a short (~10s) heating cycle to about 300°C

Before:



After:

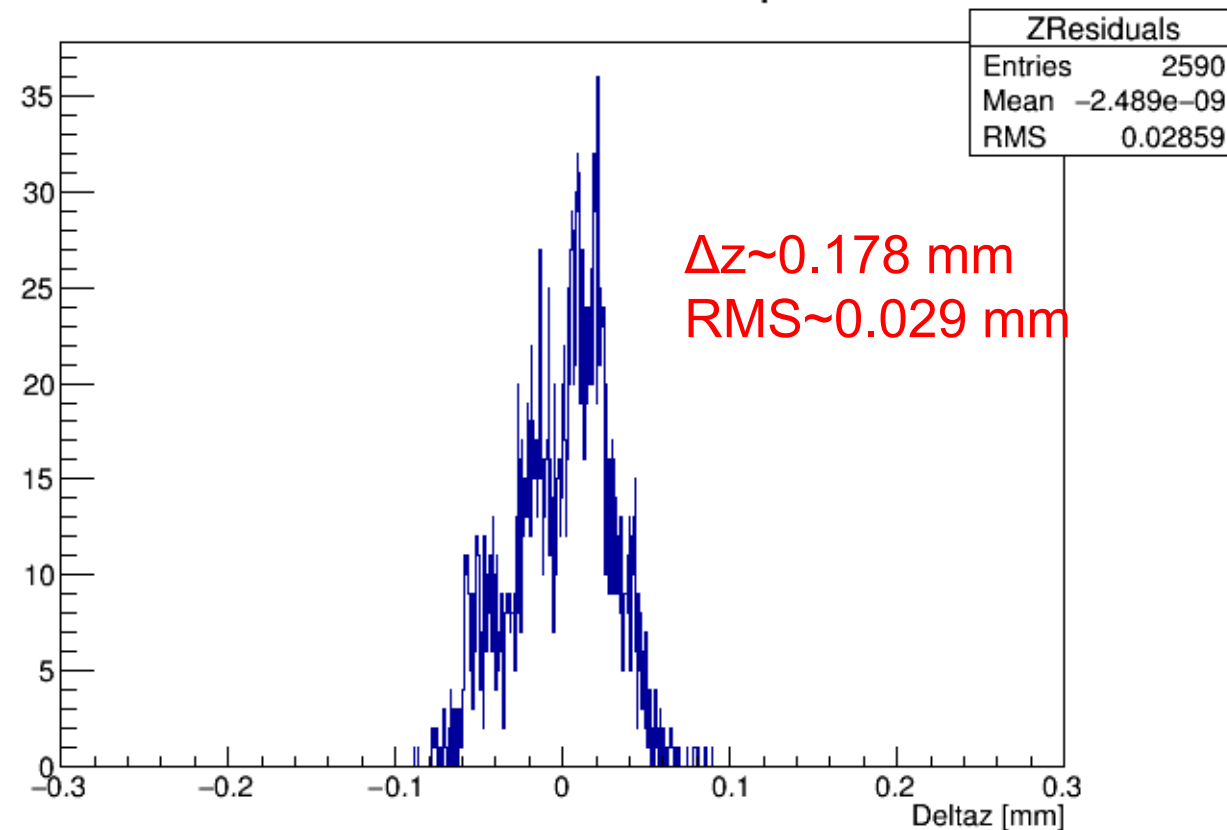


Measurements with Zeiss Acura

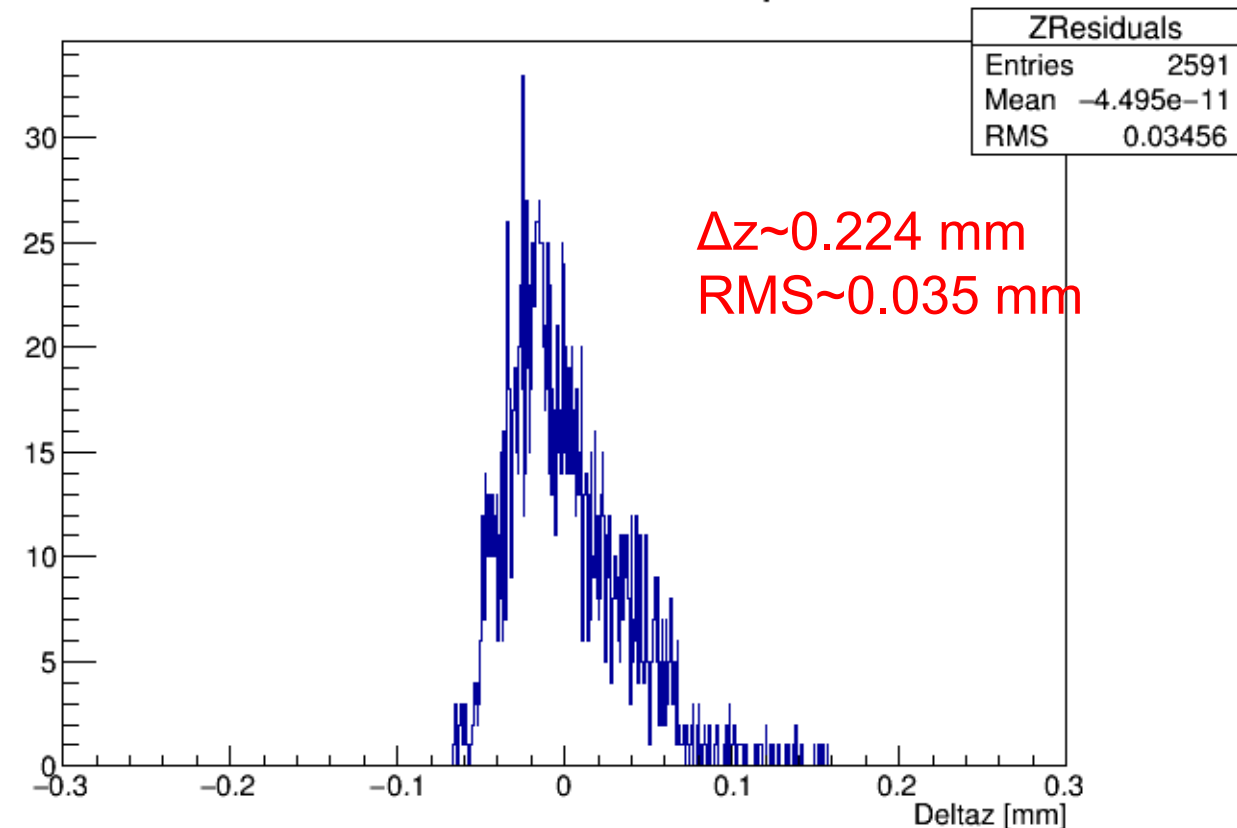
A. Thiebault, D. Zerwas + Mechanics Department of IJCLab

A plane was fitted to the point cloud of measurements
Residuals w.r.t. fitted plane

Before: Residuals wrt to fitted plane



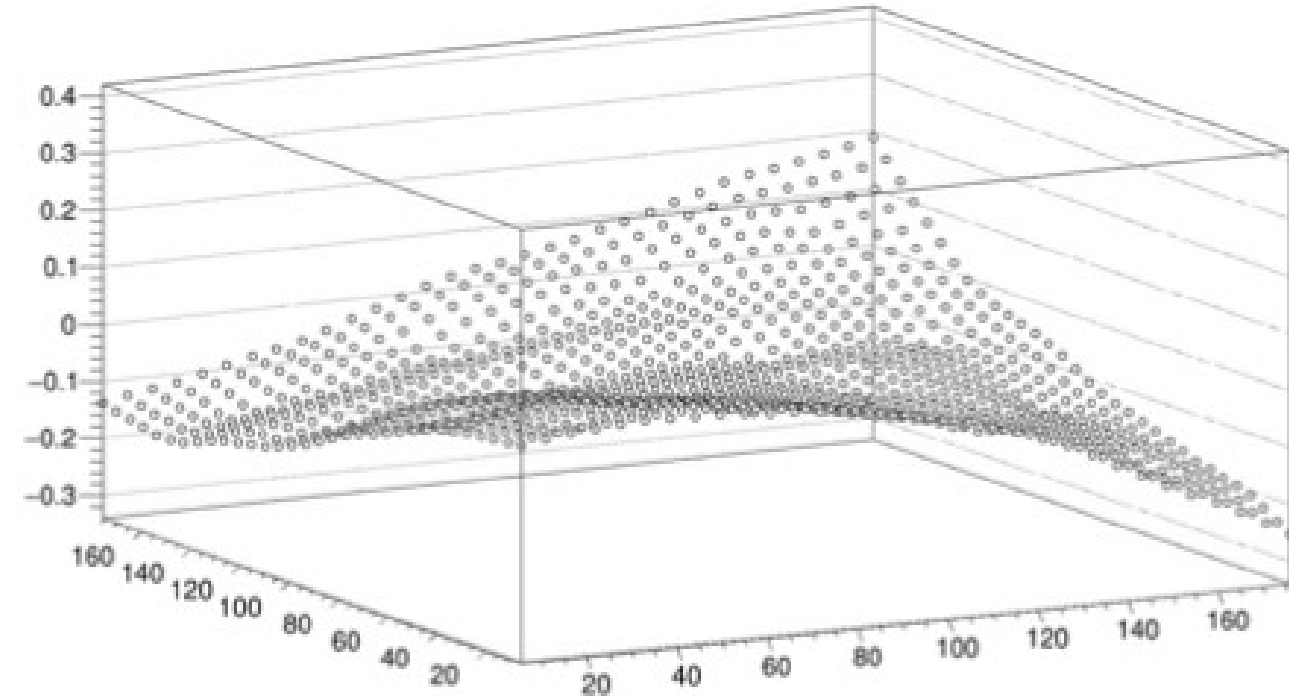
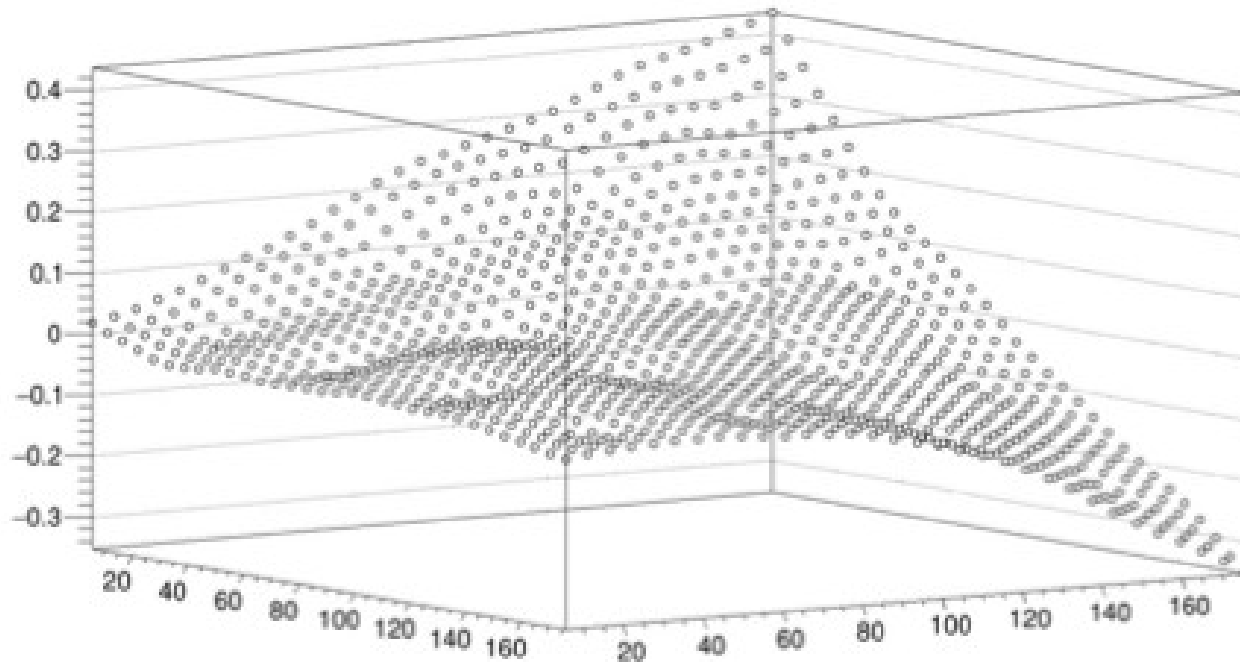
After: Residuals wrt to fitted plane



- Major part of deformation before mounting of component
- Recent measurement confirms deformation of “naked board” and allows for estimating systematic error to be of O(10μm)

A. Thiebault, D. Zerwas + Mechanics Department of IJCLab

Measurement device: Mitutoyo Quick Vision Accel, Modelo 808



- **Current results are surprising**
 - Left: Equipped PCB after reception at IFIC from IJCLab, up to 800um deformation
 - N.B.: to be compared with right hand sides on previous two slides
 - Right: Same PCB after having been carefully “dried out”, deformation reduced to 450um)
 - In addition the PCB was subject to humidity cycles
- **Systematic study to understand differences between IFIC and IJCLab ongoing**
 - Metrology with well defined protocol

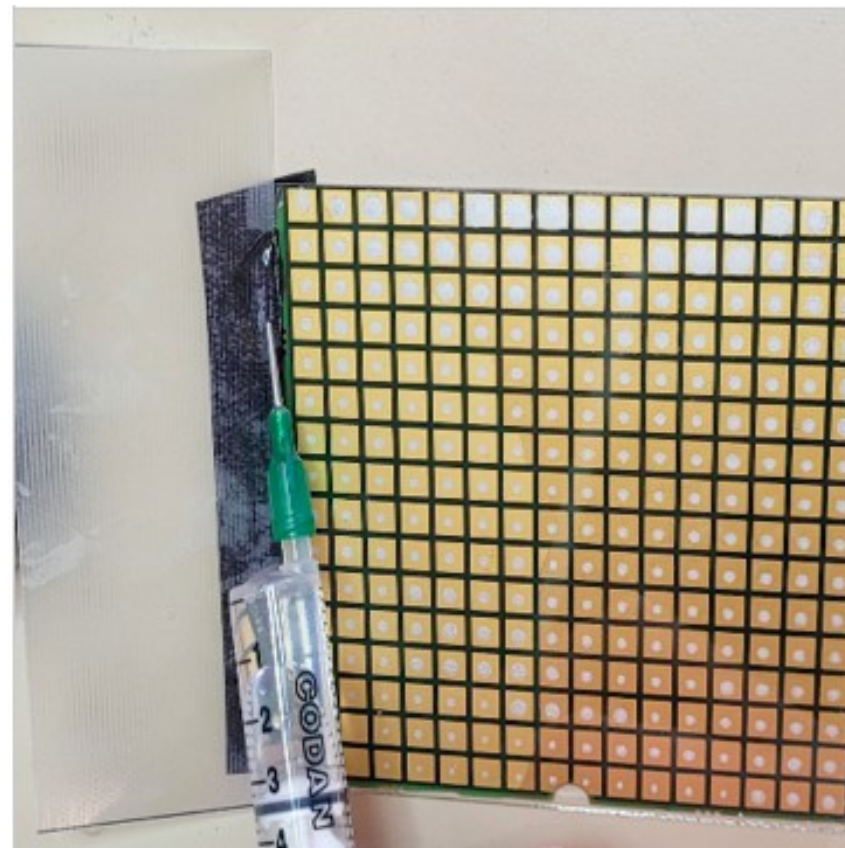
Support conductive glue dots with supplementary potting resin

EPO-TEK® 301-2



- From data sheet
 - Two component optical and semiconductor grade epoxy resin
 - Low viscosity, long potlife and good handling characteristics

Injection of underfill



- Resin propagates via capillary effect
- Takes ~20 min. to fill 9x9 cm² surface

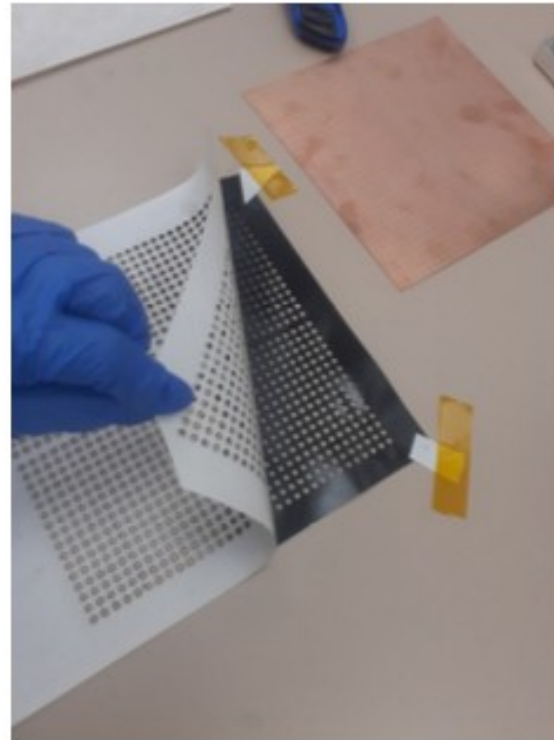
Requires curing at 80°C ...



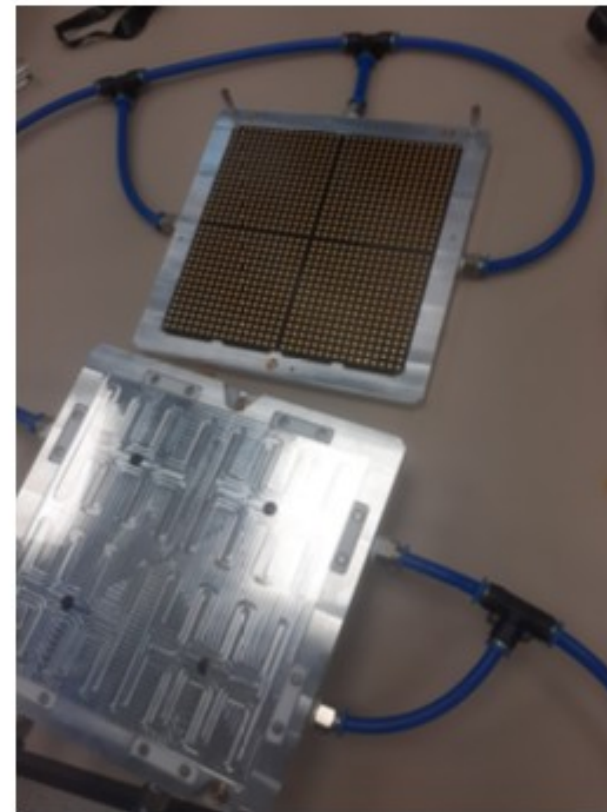
... but remains flexible after curing

A. Thiebault, A. Gallas+ Mechanics Department of IJCLab

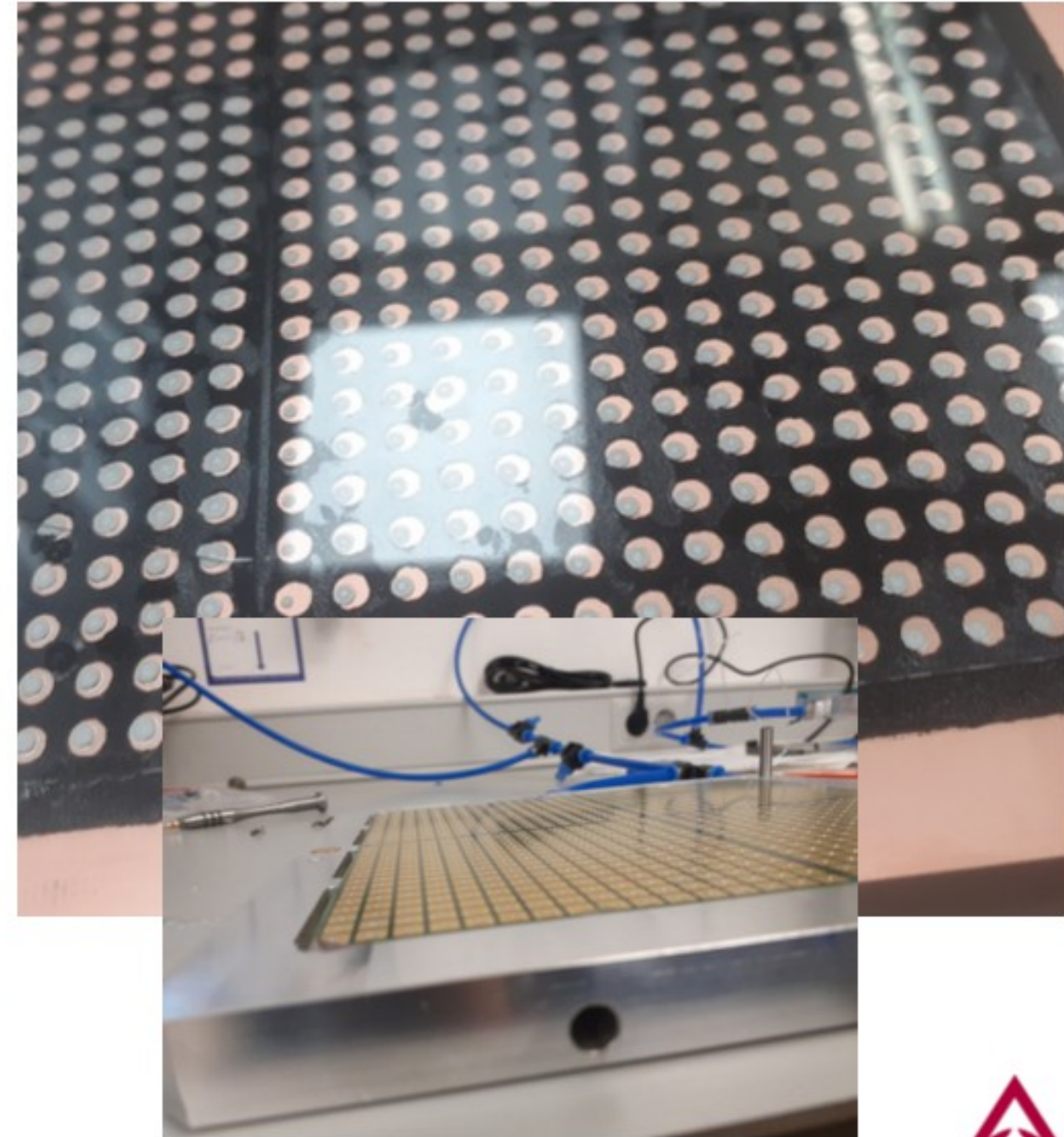
- Perforated stencil of thin 250um double tape 3M VHB 5907F
- Idea inspired by CMS HGCAL



Stencil made at IFIC (laser drill)



One 18x18cm² model completed at IFIC



A. Irlas, D. Zerwas + Mechanics Department of IJCLab

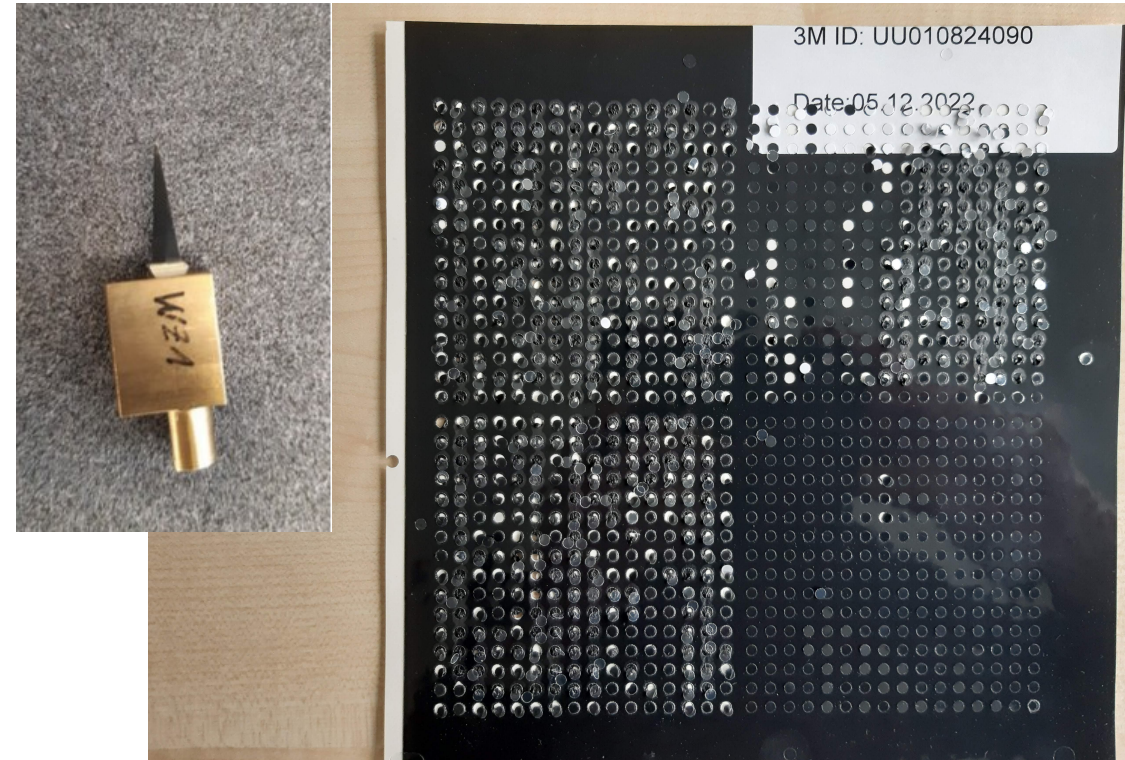
Aristo@DESY



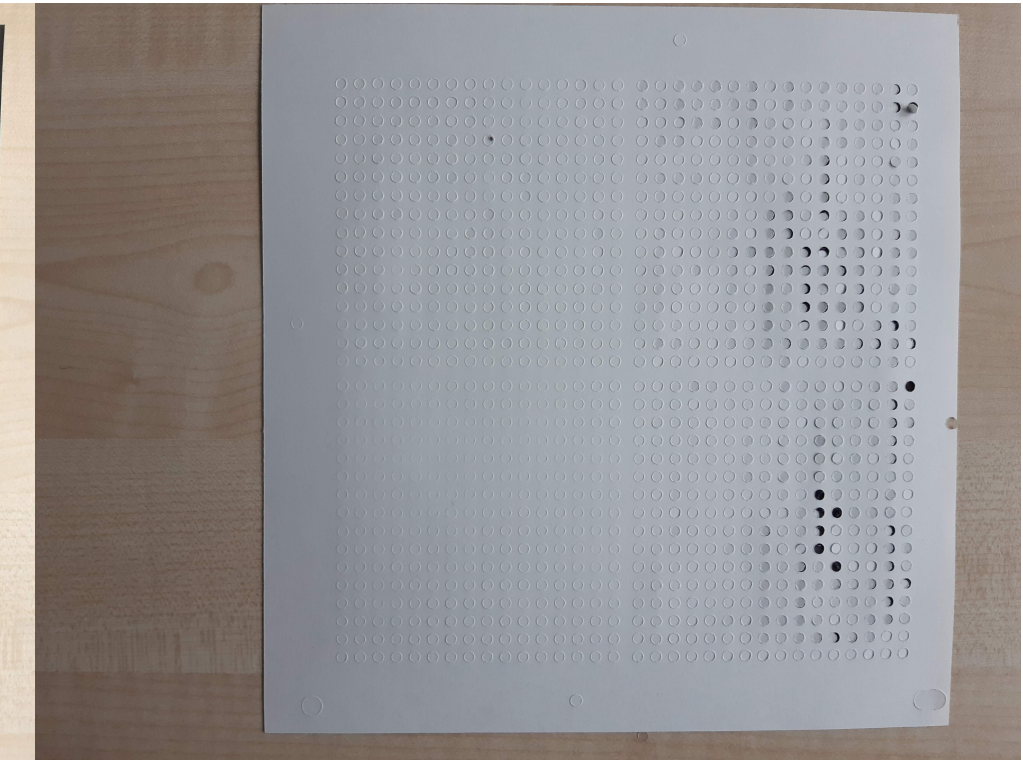
Die cutter



3M Front Side

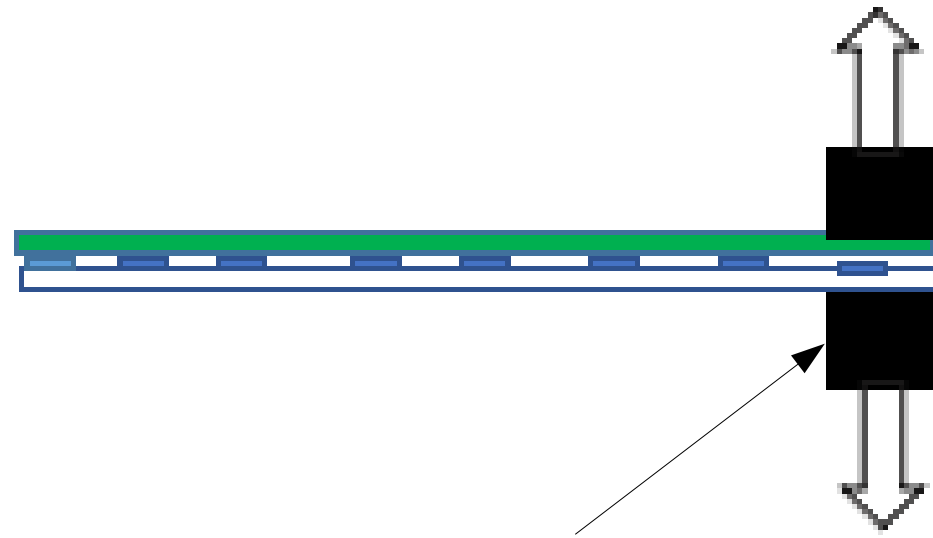


3M Back Side

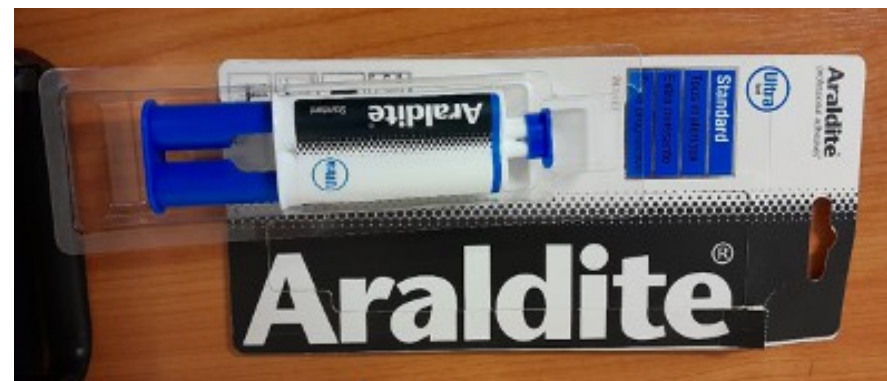


- 1024 holes in 15 minutes
 - Much faster than laser cutting
- Action coordinated by DMLAB (French-German Lab)
 - Help by DESY engineers !!!

Principle of tensile test

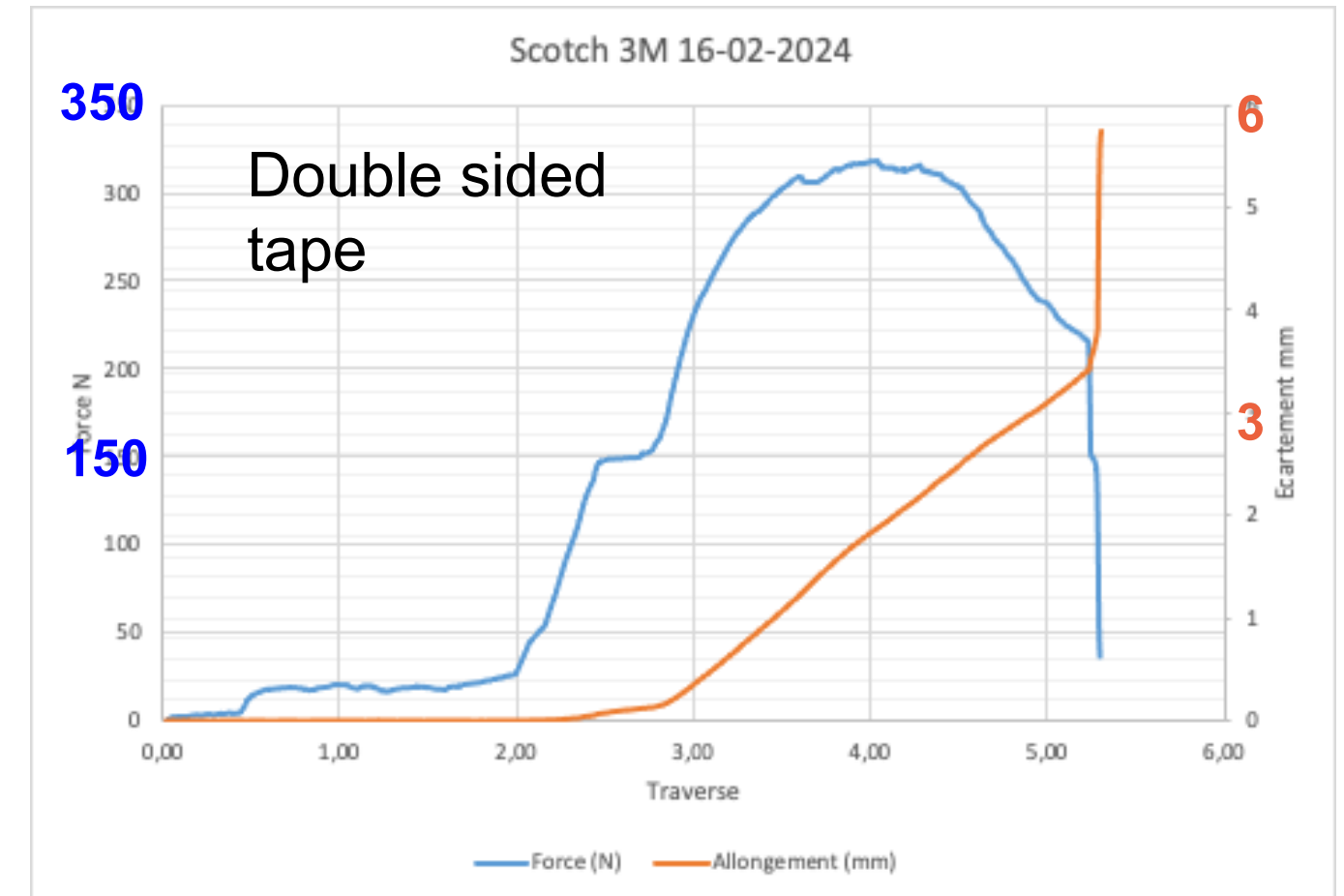
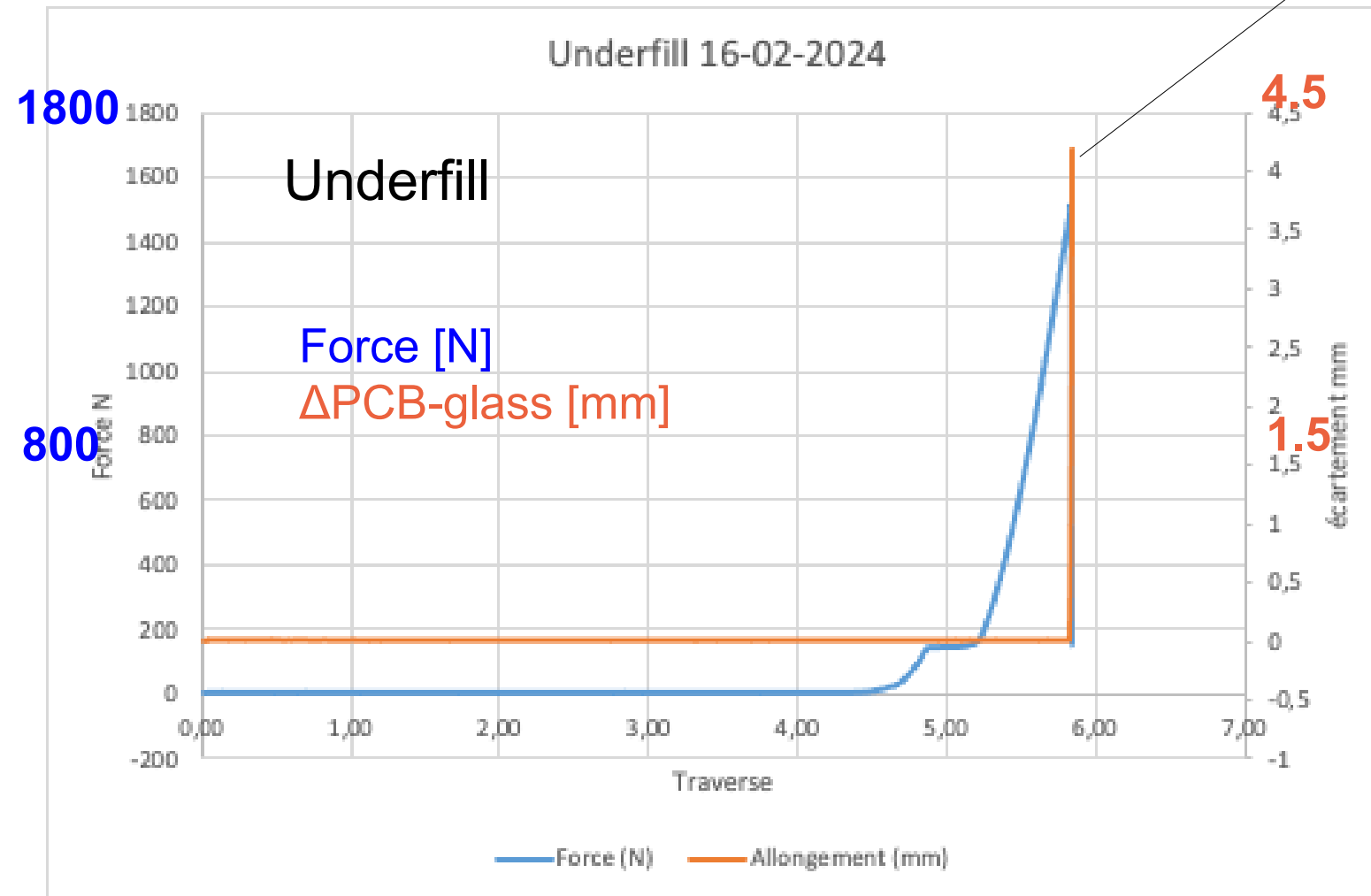


Bars are glued
to transmit force
to card under test

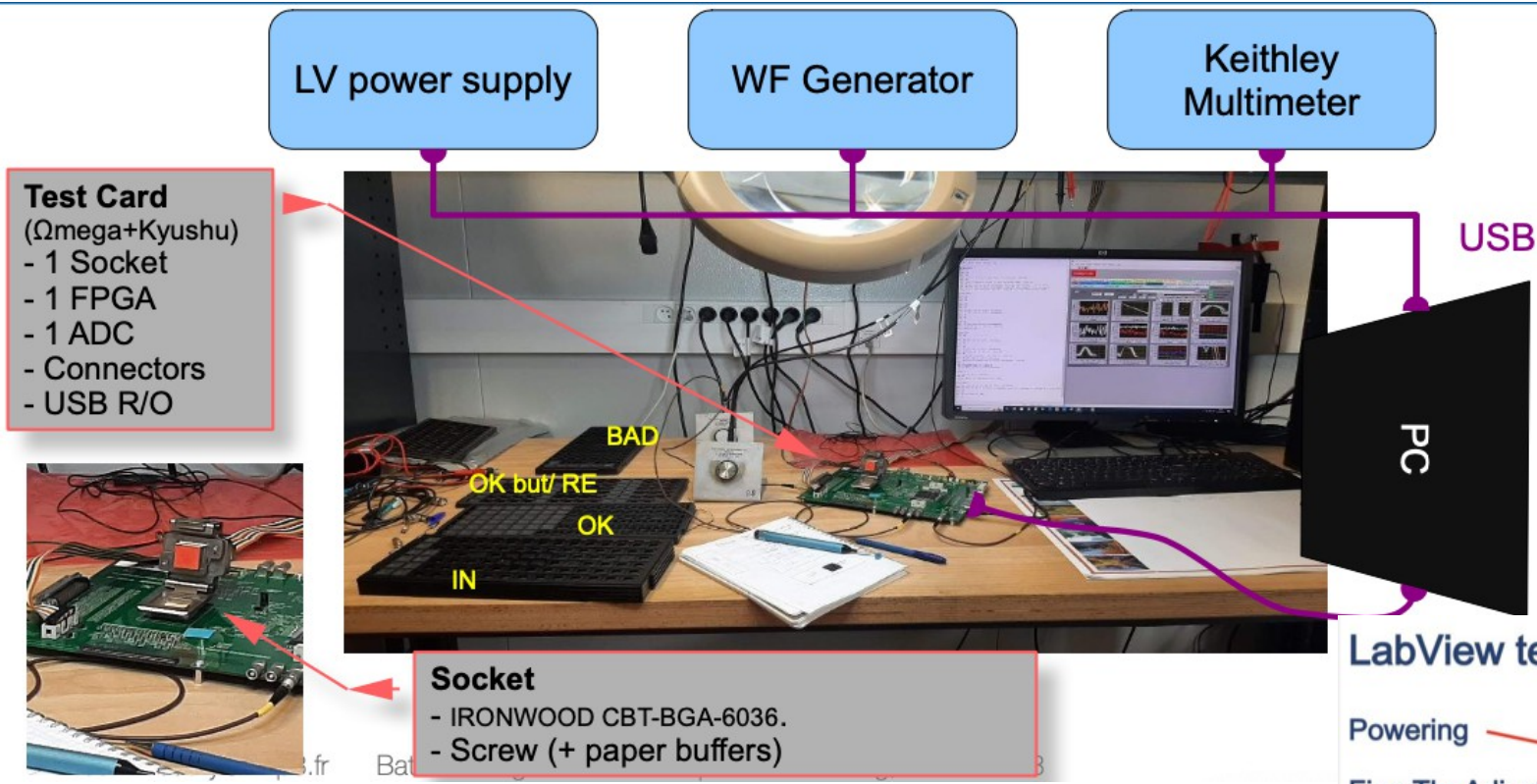


A. Thiebault + Mechanics Department of IJCLab

Bar dissolves from card under test



- First test reveals that underfill resists to even strong external forces
- Set up to measure actual force on glue dots in place (but no results yet)

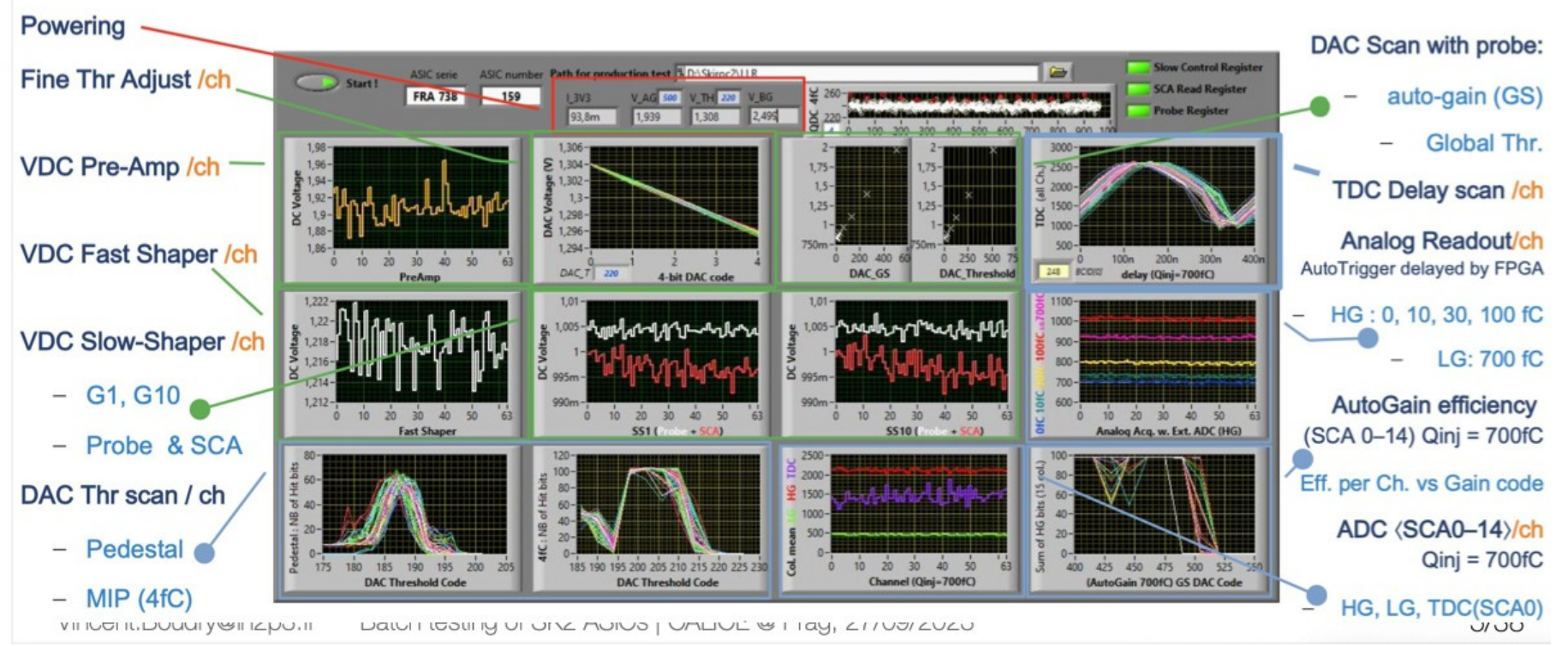


Testprotocol by OMEGA

LabView testing SW : Digital & Analogue probing 9 mins per ASIC (optim) © S. Callier

Testbench at LLR

- 151/400 SKIROCs tested until September 2023 (more since)
- Satisfactory yield



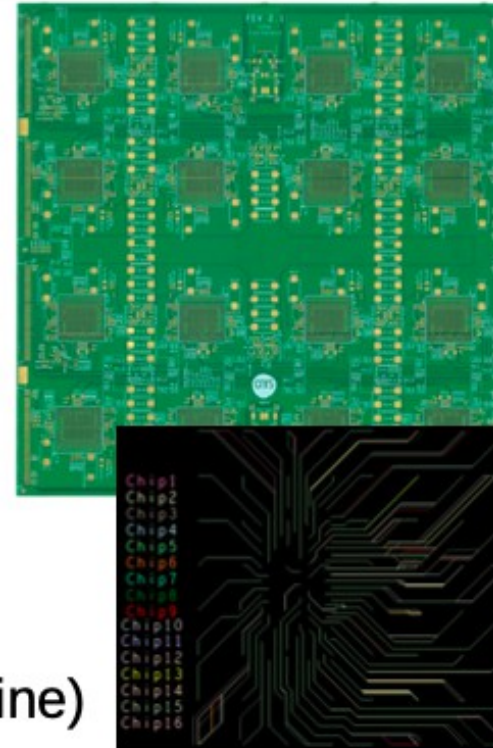
New FE boards

Improvements:

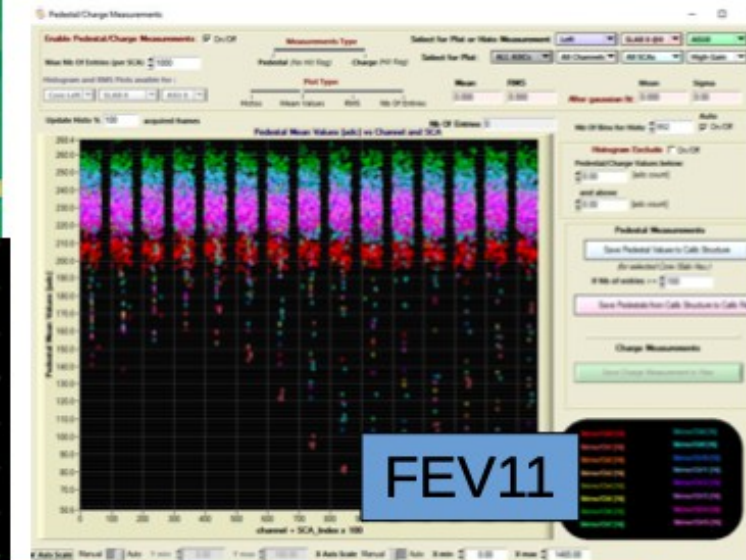
- Power distributions
 - Local power regulation
 - Local High Voltage filtering & Supply
- Signal distribution (buffering), data paths
- Monitoring (single ID, temp, probe analogue line)
- ASIC shielding/routing

Status:

- pre-version 2.0 tested, minor corrections needed
 - Noise uniformity dramatically improved (ex: outliers in thr. / 20 !)
- version 2.1 produced, ... in metrology
 - before cabling, 2nd metrology, gluing, ...
 - All material available : ASICs being tested

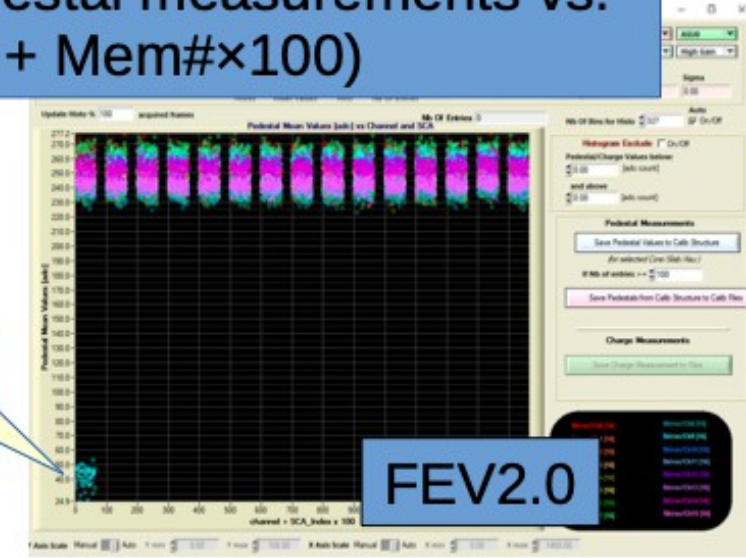


LLR, IJCLab, LPNHE, OMEGA



FEV11

Pedestal measurements vs. Ch# + Mem#×100)



Single channel → the fault on the ASIC/packageing

FEV2.0

Goal: build 15 layer stack based on these Boards

- **Slow but steady progress on SiW Ecal**
 - Visible progress on data analysis
 - Need to ensure knowledge transfer since PhD student(s) are on leave
 - New PCBs available
 - ASICs available
 - Sensors for revision of CALICE stack available
- **Understanding of sensor delamination problem are at the heart of current R&D**
 - **Systematic studies throughout 2023 and ongoing**
 - Metrology seems to indicate that component mounting is not culprit for deformation
 - Drying seems to help, avoid humidity?
 - Discrepancies between screening results at IJCLab and IFIC to be understood
- **Progress on two methods for for hybridisation**
 - Underfill
 - Double sided tape (after all a “pre-polymerised” material)
 - Have to learn now how to build ASUs using these technologies
 - Proper perforation and placement of perforated tape
 - Application of underfill to 18x18 cm² surface
- **Next steps**
 - ... build two new layers still in 2024
 - ... and extend to 15 layers if resources will permit

Backup

Laser Und Xfel Experiment – QED in extreme fields

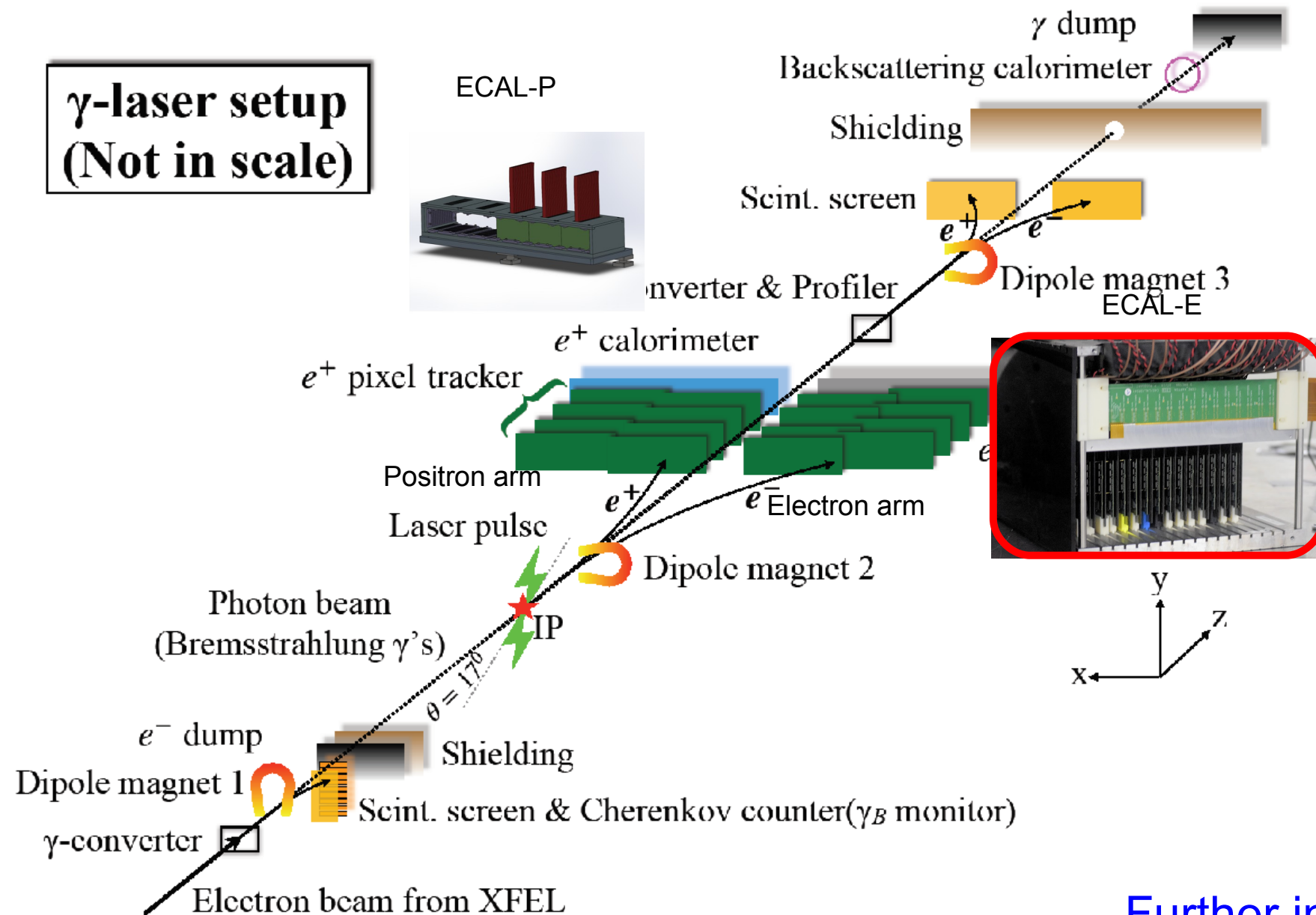


Granular calorimeters in positron and electron arms of spectrometer

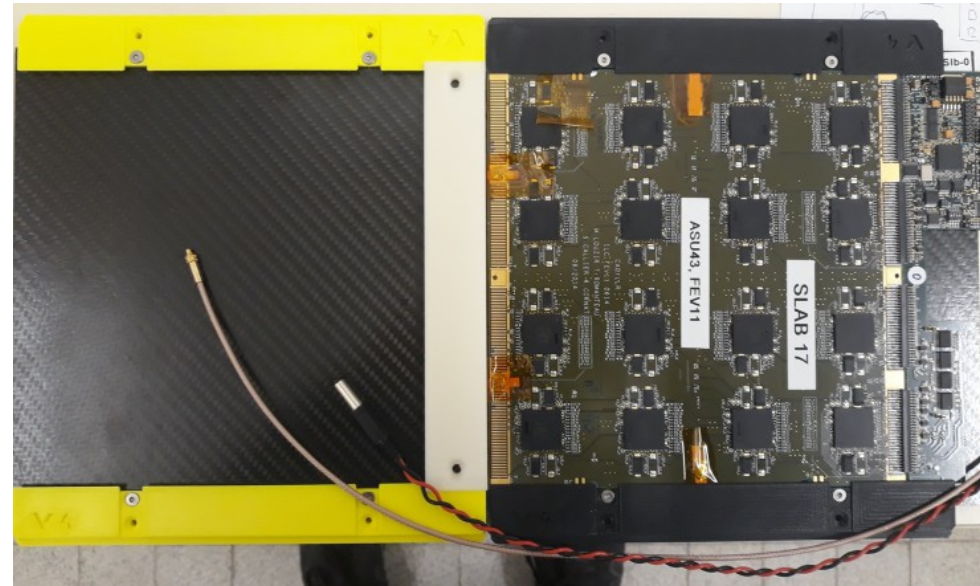
- Our focus ECAL-E
- Main application electron measurement of Breit-Wheeler process in γ -laser setup
- Could also be used in early LUXE phase in case of delays of ECAL-P
 - *Dark photon search next to γ dump could be further option*
 - *Note here that already our short layers would have (almost) sufficient acceptance*
- Ideal application(s) of CALICE SiW Ecal technological prototype

Further interest by dark photon experiments
 EBES (KEK) and Lohengrin (Uni Bonn)

**γ -laser setup
 (Not in scale)**

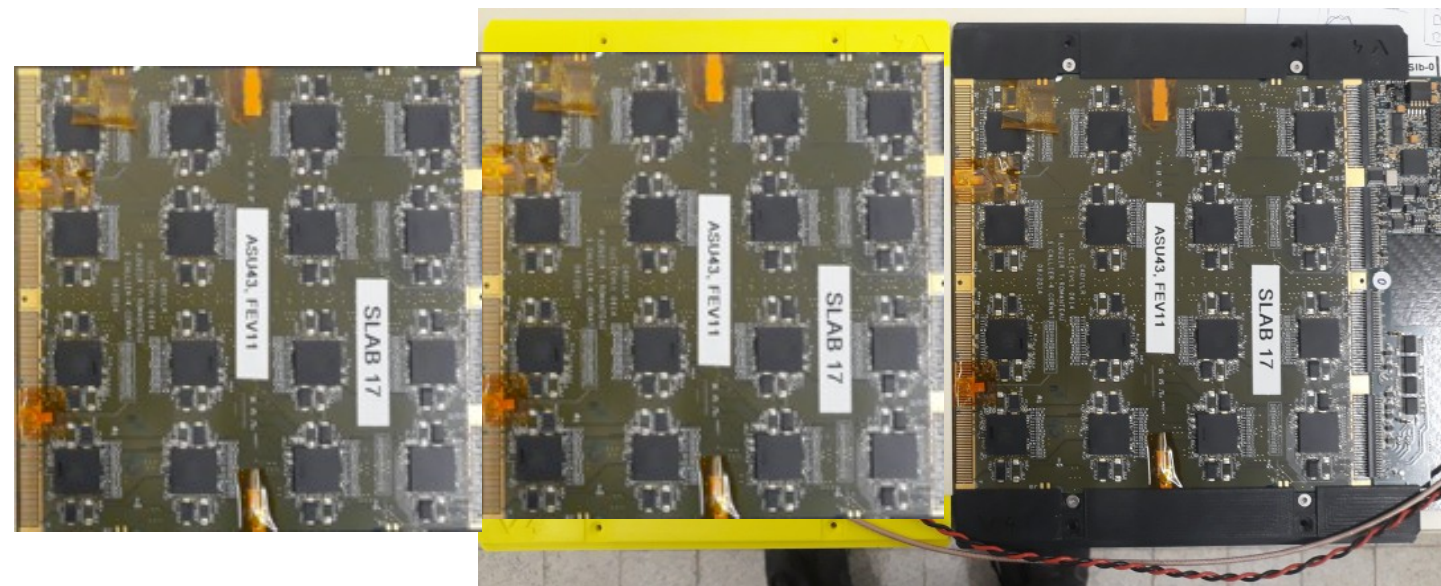


Current: Tower of 15 18x18cm² layers



- Stack under revision
- Revision possible with small amount of funding
- Revised stack should/could be available during 2024

Future: Lateral extension to up to 18x54cm² layer (three towers), up to 15 layers of this type



- Straightforward application of work for CALICE
- **Details of implementation in LUXE requires simulation study**
- **=> need dedicated funding including person power!**
- LUXE stack = v0 of SiW ECAL engineering prototype

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